

FORM PTO 1449 (modified) U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE LIST OF REFERENCES CITED BY APPLICANT(S) <i>(Use several sheets if necessary)</i> Date Submitted to PTO: June 24, 2003			ATTY DOCKET NO. 2003-0865		SERIAL NO. NEW		
			APPLICANT Norio KIMURA et al.				
			FILING DATE June 24, 2003		GROUP		
U.S. PATENT DOCUMENTS							
*EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
<i>JB</i>	AA	5,081,796	1/1992	Schultz	—	—	
	AB	5,672,091	9/1997	Takahashi et al.	—	—	
	AC	6,045,439	4/2000	Birang et al.	—	—	
	AD	6,217,411	4/2001	Hiyama et al.	—	—	
	AE	6,354,907	3/2002	Satoh et al.	—	—	
	AF	5,609,511	3/1997	Moriyama et al.	—	—	
	AG	5,738,573	4/1998	Yueh	—	—	
	AH	5,868,609	2/1999	Aaron et al.	—	—	
	AI	5,951,368	9/1999	Watanabe et al.	—	—	
	AJ	6,213,844	4/2001	Lenkersdorfer	—	—	
	AK	6,436,832	8/2002	Ma et al.	—	—	
	AL	6,443,814	9/2002	Miller et al.	—	—	
	AM	Re. 34,425	11/1993	Schultz	—	—	
<i>JB</i>	AN	2002/0023715	2/2002	Kimura et al.	—	—	
FOREIGN PATENT DOCUMENTS							
		DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION YES NO
<i>JB</i>	AO	08-139060	5/1996	JP	—	—	abstract only
	AP				—	—	
	AQ				—	—	
OTHER DOCUMENT(S) (Including Author, Title, Date, Pertinent Pages, Etc.)							
	AR						
EXAMINER	<i>Hadi Blawie</i>		DATE CONSIDERED		03/26/04		

*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

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<i>DB</i>	AA	5,421,768	6/1995	Fujiwara et al.	—	—		
	AB	5,514,245	5/1996	Doan et al.	—	—		
	AC	5,540,810	7/1996	Sandhu et al.	—	—		
	AD	5,716,264	2/1998	Kimura et al.	—	—		
	AE	5,855,804	1/1999	Walker	—	—		
	AF	5,945,347	8/1999	Wright	—	—		
	AG	6,113,465	9/2000	Kim et al.	—	—		
	AH	6,120,347	9/2000	Sandhu et al.	—	—		
	AI	6,120,354	9/2000	Koos et al.	—	—		
	AJ	6,162,368	12/2000	Li et al.	—	—		
	AK	6,217,410	4/2001	Holzapfel et al.	—	—		
	AL	6,220,941	4/2001	Fishkin et al.	—	—		
	AM	6,261,158	7/2001	Holland et al.	—	—		
	AN	6,283,840	9/2001	Huey	—	—		
	AO	6,319,098	11/2001	Osterheld et al.	—	—		
<i>DB</i>	AP	6,435,942	8/2002	Jin et al.	—	—		
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